Search Notes				

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/719,557	SWANSON ET AL	•
Examiner	Art Unit	
SANG KIM	3654	

SEARCHED				
Class	Subclass	Date	Examiner	
242	615.1	7-7-05	514	
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undered all above	9	1-5-06	SIC	
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
John Novyen 242/6/5.2	7-7-2	sk	
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